

Horizontal Genlock, 8F_{SC}

The EL4585 is a PLL (Phase Lock Loop) sub-system, designed for video applications and also suitable for general purpose use up to 36MHz. In video applications, this device generates a TTL/CMOS-compatible pixel clock (CLK OUT) which is a multiple of the TV horizontal scan rate and phase locked to it.

The reference signal is a horizontal sync signal, TTL/CMOS format, which can be easily derived from an analog composite video signal with the EL4583 sync separator. An input signal to "coast" is provided for applications where periodic disturbances are present in the reference video timing such as VTR head switching. The lock detector output indicates correct lock.

The divider ratio is four ratios for NTSC and four similar ratios for the PAL video timing standards by external selection of three control pins. These four ratios have been selected for common video applications including 8F_{SC}, 6F_{SC}, 27MHz (CCIR 601 format) and square picture elements used in some workstation graphics. To generate 4F_{SC}, 3F_{SC}, 13.5MHz (CCIR 601 format) etc., use the EL4584, which does not have the additional divide-by-two stage of the EL4585.

For applications where these frequencies are inappropriate or for general purpose PLL applications the internal divider can be bypassed and an external divider chain used.

FREQUENCIES AND DIVISORS

FUNCTION	6F _{SC} (Note 1)	CCIR 601 (Note 2)	SQUARE (Note 3)	8F _{SC}
Divisor (Note 4)	1702	1728	1888	2270
PAL F _{OSC} (MHz)	26.602	27.0	29.5	35.468
Divisor (Note 4)	1364	1716	1560	1820
NTSC F _{OSC} (MHz)	21.476	27.0	24.546	28.636

NOTES:

1. 6F_{SC} frequencies do not yield integer divisors.
2. CCIR 601 divisors yield 1440 pixels in the active portion of each line for NTSC and PAL.
3. Square pixels format gives 640 pixels for NTSC and 768 pixels for PAL.
4. Divisor does not include ÷ 2 block.

Features

- 36MHz, general purpose PLL
- 8F_{SC} timing (use the EL4584 for 4F_{SC})
- Compatible with EL4583 sync separator
- VCXO, Xtal, or LC tank oscillator
- < 2ns jitter (VCXO)
- User-controlled PLL capture and lock
- Compatible with NTSC and PAL TV formats
- 8 pre-programmed popular TV scan rate clock divisors
- Single 5V, low current operation
- Pb-Free Available (RoHS Compliant)

Applications

- Pixel clock regeneration
- Video compression engine (MPEG) clock generator
- Video capture or digitization
- PIP (Picture in Picture) timing generator
- Text or graphics overlay timing

Ordering Information

PART NUMBER	PART MARKING	PACKAGE	PKG. DWG. #
EL4585CN	EL4585CN	16 Ld PDIP	E16.3
EL4585CS	EL4585CS	16 Ld SOIC	MDP0027
EL4585CS-T7*	EL4585CS	16 Ld SOIC	MDP0027
EL4585CS-T13*	EL4585CS	16 Ld SOIC	MDP0027
EL4585CSZ (Note 5)	EL4585CSZ	16 Ld SOIC (Pb-free)	MDP0027
EL4585CSZ-T7* (Note 5)	EL4585CSZ	16 Ld SOIC (Pb-free)	MDP0027
EL4585CSZ-T13* (Note 5)	EL4585CSZ	16 Ld SOIC (Pb-free)	MDP0027

*Please refer to TB347 for details on reel specifications.

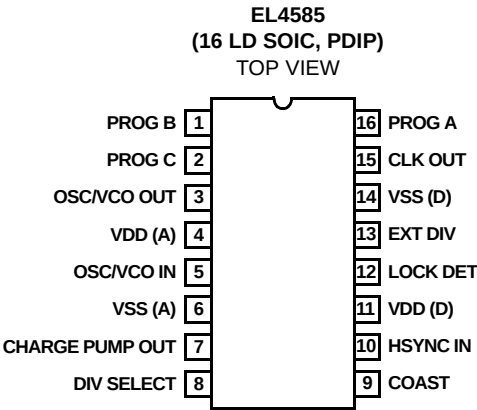
NOTES:

5. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.
6. For 3F_{SC} and 4F_{SC} clock frequency operation, see EL4584 datasheet.

Demo Board

A demo PCB is available for this product.

Pinout



Absolute Maximum Ratings ($T_A = +25^\circ\text{C}$)

V_{CC} Supply7V
 Storage Temperature -65°C to $+150^\circ\text{C}$
 Pin Voltages -0.5V to $V_{CC} + 0.5\text{V}$

Operating Conditions

Temperature Range -40°C to $+85^\circ\text{C}$

Thermal Information

Thermal Resistance (Typical, Note 7) θ_{JA} ($^\circ\text{C}/\text{W}$)
 16 Lead PDIP 70
 16 Lead SOIC 80
 Operating Junction Temperature $+125^\circ\text{C}$
 Power Dissipation 400mW
 Oscillator Frequency 36MHz

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTE:

7. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typical values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore: $T_J = T_C = T_A$

DC Electrical Specifications $V_{DD} = 5\text{V}$, $T_A = +25^\circ\text{C}$ unless otherwise noted.

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
I_{DD}	$V_{DD} = 5\text{V}$ (Note 8)		2	4	mA
V_{IL} Input Low Voltage				1.5	V
V_{IH} Input High Voltage		3.5			V
I_{IL} Input Low Current	All inputs except COAST, $V_{IN} = 1.5\text{V}$	-100			nA
I_{IH} Input High Current	All inputs except COAST, $V_{IN} = 3.5\text{V}$			100	nA
I_{IL} Input Low Current	COAST pin, $V_{IN} = 1.5\text{V}$	-100	-60		μA
I_{IH} Input High Current	COAST pin, $V_{IN} = 3.5\text{V}$		60	100	μA
V_{OL} Output Low Voltage	Lock Det, $I_{OL} = 1.6\text{mA}$			0.4	V
V_{OH} Output High Voltage	Lock Det, $I_{OH} = -1.6\text{mA}$	2.4			V
V_{OL} Output Low Voltage	CLK, $I_{OL} = 3.2\text{mA}$			0.4	V
V_{OH} Output High Voltage	CLK, $I_{OH} = -3.2\text{mA}$	2.4			V
V_{OL} Output Low Voltage	OSC Out, $I_{OL} = 200\mu\text{A}$			0.4	V
V_{OH} Output High Voltage	OSC Out, $I_{OH} = -200\mu\text{A}$	2.4			V
I_{OL} Output Low Current	Filter Out, $V_{OUT} = 2.5\text{V}$	200	300		μA
I_{OH} Output High Current	Filter Out, $V_{OUT} = 2.5\text{V}$		-300	-200	μA
I_{OL}/I_{OH} Current Ratio	Filter Out, $V_{OUT} = 2.5\text{V}$	1.05	1.0	0.95	
I_{LEAK} Filter Out	Coast Mode, $V_{DD} > V_{OUT} > 0\text{V}$	-100	± 1	100	nA

NOTE:

8. All inputs to 0V, COAST floating.

AC Electrical Specifications $V_{DD} = 5\text{V}$, $T_A = +25^\circ\text{C}$ unless otherwise noted

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
VCO Gain @ 20MHz	Test circuit 1		15.5		dB
H_{SYNC} S/N Ratio	$V_{DD} = 5\text{V}$ (Note 9)	35			dB
Jitter	VCXO oscillator		1		ns
Jitter	LC oscillator (Typ)		10		ns

NOTE:

9. Noisy video signal input to EL4583, H_{SYNC} input to EL4585. Test for positive signal lock.

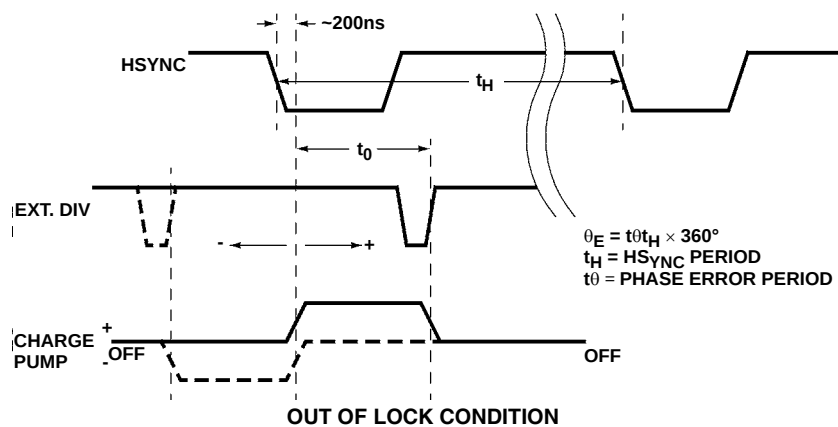
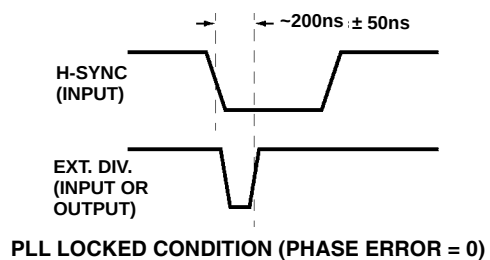
Pin Descriptions

Pin NUMBER	PIN NAME	FUNCTION
1, 2, 16	PROG B, C, A	Digital inputs to select $\div N$ value for internal counter. See Table 1 for values.
3	OSC/VCO OUT	Output of internal inverter/oscillator. Connect to external crystal or LC tank VCO circuit.
4	VDD (A)	Analog positive supply for oscillator, PLL circuits.
5	OSC/VCO IN	Input from external VCO.
6	VSS (A)	Analog ground for oscillator, PLL circuits.
7	CHARGE PUMP OUT	Connect to loop filter. If the H _{SYNC} phase is leading or H _{SYNC} frequency > CLK $\div$ 2N, current is pumped into the filter capacitor to increase VCO frequency. If H _{SYNC} phase is lagging or frequency < CLK $\div$ 2N, current is pumped out of the filter capacitor to decrease VCO frequency. During coast mode or when locked, charge pump goes to a high impedance state.
8	DIV SELECT	Divide select input. When high, the internal divider is enabled and EXT DIV becomes a test pin, outputting CLK $\div$ 2N. When low, the internal divider is disabled and EXT DIV is an input from an external $\div N$.
9	COAST	Three-state logic input. Low (< 1/3*V _{CC}) = normal mode, Hi Z (or 1/3 to 2/3*V _{CC}) = fast lock mode, High (> 2/3*V _{CC}) = coast mode.
10	HSYNC IN	Horizontal sync pulse (CMOS level) input.
11	VDD (D)	Positive supply for digital, I/O circuits.
12	LOCK DET	Lock detect output. Low level when PLL is locked. Pulses high when out of lock.
13	EXT DIV	External divide input when DIV SEL is low, internal $\div$ 2N output when DIV SEL is high.
14	VSS (D)	Ground for digital, I/O circuits.
15	CLK OUT	Buffered output of the VCO.

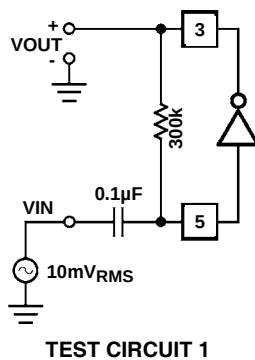
TABLE 1. VCO DIVISORS

PROG A (PIN 16)	PROG B (PIN 1)	PROG C (PIN 2)	DIV VALUE (N)
0	0	0	1702
0	0	1	1728
0	1	0	1888
0	1	1	2270
1	0	0	1364
1	0	1	1716
1	1	0	1560
1	1	1	1820

Timing Diagrams



Test Circuit



Typical Performance Curves

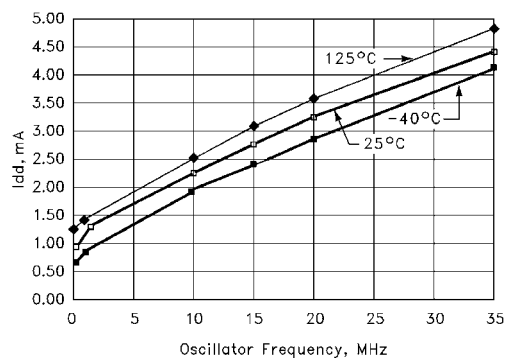
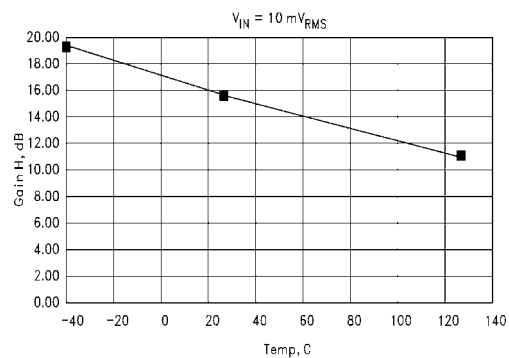
FIGURE 1. I_{DD} vs F_{OSC}

FIGURE 2. OSC GAIN @ 20MHz vs TEMP

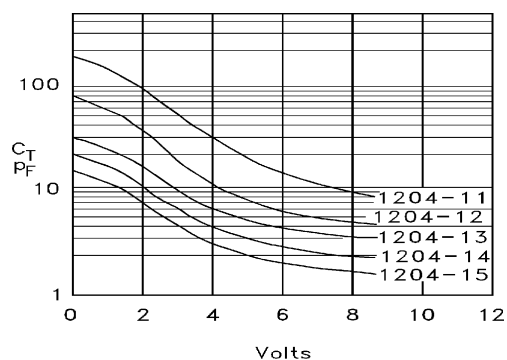
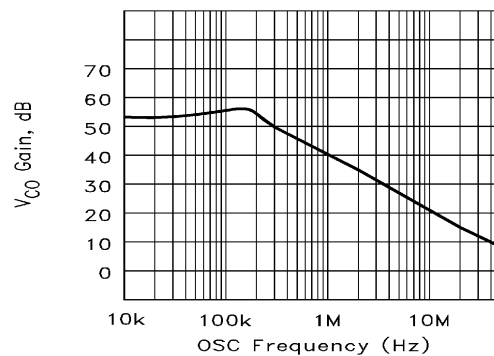
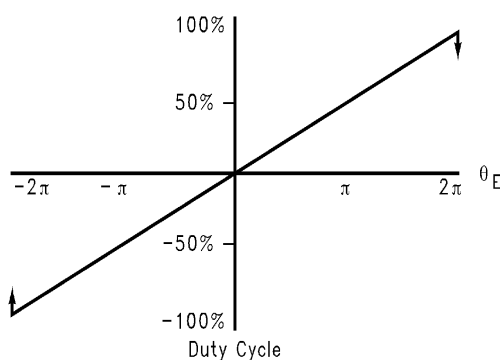


FIGURE 3. TYPICAL VARACTOR

FIGURE 4. OSC GAIN vs F_{OSC}FIGURE 5. CHARGE PUMP DUTY CYCLE vs θ_E

varactor within this range. Crystal oscillators are more stable than LC oscillators, which translates into lower jitter, but LC oscillators can be pulled from their mid-point values further, resulting in a greater capture and locking range. If the incoming horizontal sync signal is known to be very stable, then a crystal oscillator circuit can be used. If the H_{SYNC} signal experiences frequency variations of greater than about 300ppm, an LC oscillator should be considered, as crystal oscillators are very difficult to pull this far. When H_{SYNC} input frequency is greater than $\text{CLK} \div 2N$, charge pump output (pin 7) sources current into the filter capacitor, increasing the voltage across the varactor, thus tending to increase VCO frequency. Conversely, charge pump output pulls current from the filter capacitor when H_{SYNC} frequency is less than $\text{CLK} \div 2N$, forcing the VCO frequency lower.

Loop Filter

The loop filter controls how fast the VCO will respond to a change in phase comparator output stimulus. Its components should be chosen so that fast lock can be achieved, yet with a minimum of VCO "hunting", preferably in one to two oscillations of charge pump output, assuming the VCO frequency starts within capture range. If the filter is under-damped, the VCO will over and under-shoot the desired operating point many times before a stable lock takes place. It is possible to under-damp the filter so much that the loop itself oscillates, and VCO lock is never achieved. If the filter is over-damped, the VCO response time will be excessive and many cycles will be required for a lock condition. Over-damping is also characterized by an easily unlocked system because the filter can't respond fast enough to perturbations in VCO frequency. A severely over damped system will seem to endlessly oscillate, like a very large mass at the end of a long pendulum. Due to parasitic effects of PCB traces and component variables, it will take some trial and error experimentation to determine the best values to use for any given situation. Use the component tables as a starting point, but be aware that deviations from these values are not out of the ordinary.

External Divide

DIV SEL (pin 8) controls the use of the internal divider. When high, the internal divider is enabled and EXT DIV (pin 13) outputs the CLK out divided by 2N. This is the signal to which the horizontal sync input will lock. When divide select is low, the internal divider output is disabled, and external divide becomes an input from an external divider, so that a divisor other than one of the 8 pre-programmed internal divisors can be used.

Normal Mode

Normal mode is enabled by pulling COAST (pin 9) low (below $1/3 \cdot V_{CC}$). If H_{SYNC} and $\text{CLK} \div 2N$ have any phase or frequency difference, an error signal is generated and sent to the charge pump. The charge pump will either force current into or out of the filter capacitor in an attempt to

modulate the VCO frequency. Modulation will continue until the phase and frequency of $\text{CLK} \div 2N$ exactly match the H_{SYNC} input. When the phase and frequency match (with some offset in phase that is a function of the VCO characteristics), the error signal goes to zero, lock detect no longer pulses high, and the charge pump enters a high impedance state. The clock is now locked to the H_{SYNC} input. As long as phase and frequency differences remain small, the PLL can adjust the VCO to remain locked and lock detect remains low.

Fast Lock Mode

Fast Lock mode is enabled by either allowing coast to float, or pulling it to mid supply (between $1/3$ and $2/3 \cdot V_{CC}$). In this mode, lock is achieved much faster than in normal mode, but the clock divisor is modified on the fly to achieve this. If the phase detector detects an error of enough magnitude, the clock is either inhibited or reset to attempt a "fast lock" of the signals. Forcing the clock to be synchronized to the H_{SYNC} input this way allows a lock in approximately 2 H-cycles, but the clock spacing will not be regular during this time. Once the near lock condition is attained, charge pump output should be very close to its lock-on value, and placing the device into normal mode should result in a normal lock very quickly. Fast lock mode is intended to be used where H_{SYNC} becomes irregular, until a stable signal is again obtained.

Coast Mode

Coast mode is enabled by pulling COAST (pin 9) high (above $2/3 \cdot V_{CC}$). In coast mode the internal phase detector is disabled and filter out remains in high impedance mode to keep filter out voltage and VCO frequency as constant as possible. VCO frequency will drift as charge leaks from the filter capacitor, and the voltage changes the VCO operating point. Coast mode is intended to be used when noise or signal degradation result in loss of horizontal sync for many cycles. The phase detector will not attempt to adjust to the resultant loss of signal so that when horizontal sync returns, sync lock can be re-established quickly. However, if much VCO drift has occurred, it may take as long to re-lock as when restarting.

Lock Detect

Lock detect (pin 12) will go low when lock is established. Any DC current path from charge pump out will skew EXT DIV relative to H_{SYNC} in, tending to offset or add to the 200ns internal delay, depending on which way the extra current is flowing. This offset is called static phase error, and is always present in any PLL system. If, when the part stabilizes in a locked mode, lock detect is not low, adding or subtracting from the loop filter series resistor R2 will change this static phase error to allow LDET to go low while in lock. The goal is to put the rising edge of EXT DIV in sync with the falling edge of H_{SYNC} + 200ns (see "Timing Diagrams" on page 5). Increasing R2 decreases phase error, while decreasing R2 increases phase error. (Phase error is

positive when EXT DIV lags H_{SYNC}.) The resistance needed will depend on VCO design or VCXO module selection.

Applications Information

Choosing External Components

1. To choose LC VCO components, first pick the desired operating frequency. For our example we will use 28.636MHz, with an H_{SYNC} frequency of 15.734kHz.
2. Choose a reasonable inductor value (1μ to 5μH works well). We choose 3.3μH.
3. Calculate C_T needed to produce F_{OSC}.

$$F_{OSC} = \frac{1}{2\pi\sqrt{LC_T}} \quad (EQ. 1)$$

$$C_T = \frac{1}{4\pi^2 F^2 L} = \frac{1}{4\pi^2 (28.636e6)^2 (3.3e-6)} = 9.4pF$$

4. From the varactor data sheet find C_V @ 2.5V, the desired lock voltage. C_V=23pF for our SMV1204-12 for example.
5. C₂ should be about 10C_V, so we choose C₂=220pF for our example.
6. Calculate C₁. Since:

$$C_T = \frac{C_1 C_2 C_V}{(C_1 C_2) + (C_1 C_V) + (C_2 C_V)} \quad (EQ. 2)$$

then:

$$C_1 = \frac{C_2 C_T C_V}{(C_2 C_V) - (C_2 C_T) - (C_T C_V)} \quad (EQ. 3)$$

For our example, C₁=17pF. (A trim capacitor may be used for fine tuning.) Examples for each frequency using the internal divider is shown in Figure 8.

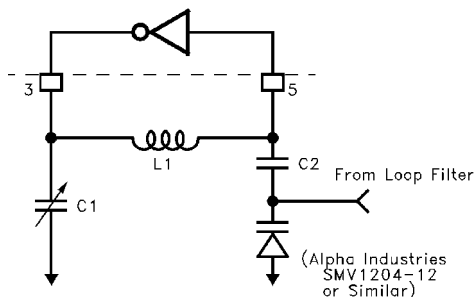


FIGURE 8. TYPICAL LC VCO

LC VCO COMPONENT VALUES (APPROXIMATE) (Note)

FREQUENCY (MHz)	L ₁ (μH)	C ₁ (pF)	C ₂ (pF)
26.602	3.3	22	220
27.0	3.3	21	220
29.5	2.7	22	220
35.468	2.2	16	220
21.476	4.7	26	220
24.546	3.9	22	220
28.636	3.3	17	220

NOTE: Use shielded inductors for optimum performance.

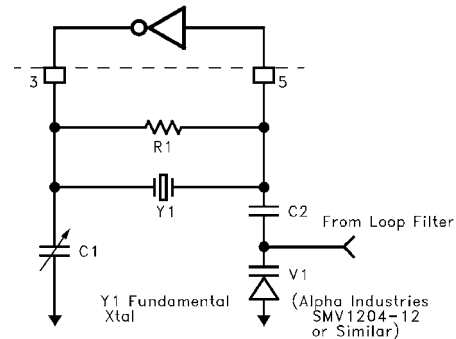
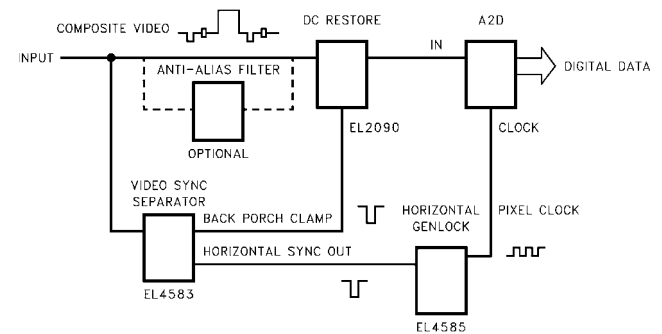


FIGURE 9. TYPICAL XTAL VCO

Typical Application



Horizontal genlock provides clock for an analog-to-digital converter, digitizing analog video.

XTAL VCO COMPONENT VALUES (APPROXIMATE)

FREQUENCY (MHz)	R ₁ (kΩ)	C ₁ (pF)	C ₂ (μF)
26.602	300	15	0.001
27.0	300	15	0.001
29.5	300	15	0.001
35.468	300	15	0.001
21.476	300	15	0.001
24.546	300	15	0.001
28.636	300	15	0.001

The oscillators are arranged as Colpitts oscillators (see Figure 8), and the structure is redrawn here to emphasize the split capacitance used in a Colpitts oscillator. It should be noted that this oscillator configuration is just one of literally hundreds possible, and the configuration shown here does not necessarily represent the best solution for all applications. Crystal manufacturers are very informative sources on the design and use of oscillators in a wide variety of applications, and the reader is encouraged to become familiar with them.

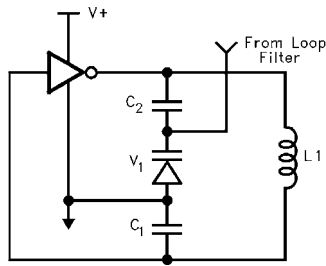


FIGURE 10. COLPITTS OSCILLATOR

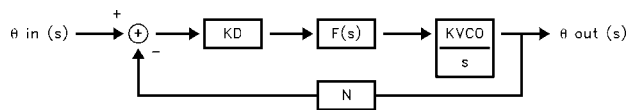
C_1 is to adjust the center frequency, C_2 DC isolates the control from the oscillator, and V_1 is the primary control device. C_2 should be much larger than C_V so that V_1 has maximum modulation capability. The frequency of oscillation is given by Equation 4:

$$F = \frac{1}{2\pi\sqrt{LC_T}} \quad (\text{EQ. 4})$$

$$C_T = \frac{C_1 C_2 C_V}{(C_1 C_2) + (C_1 C_V) + (C_1 C_V)}$$

Choosing Loop Filter Components

The PLL, VCO, and loop filter can be described as:



Where:

K_d = phase detector gain in A/rad

$F(s)$ = loop filter impedance in V/A

K_{VCO} = VCO gain in rad/s/V

N = Total internal or external divisor (see 3 below)

It can be shown that for the loop filter shown in Equation 5:

$$C_3 = \frac{K_d K_{VCO}}{N \omega_n^2}, C_4 = \frac{C_3}{10}, R_3 = \frac{2N\zeta\omega_n}{K_d K_{VCO}} \quad (\text{EQ. 5})$$

Where ω_n = loop filter bandwidth, and ζ = loop filter damping factor.

1. $K_d = 300\mu\text{A}/2\pi\text{rad} = 4.77\text{e-}5\text{A/rad}$ for the EL4585.
2. The loop bandwidth should be about H_{SYNC} frequency/20, and the damping ratio should be 1 for optimum performance. For our example, $\omega_n = 15.734\text{kHz}/20 = 787\text{ Hz} \approx 5000\text{ rad/S}$.
3. $N = 910 \times 2 = 1820$ from Table 1.

$$N = \frac{F_{VCO}}{F_{H_{\text{sync}}}} = \frac{28.636\text{M}}{15.73426\text{k}} = 1820 = 910 \times 2 \quad (\text{EQ. 6})$$

4. K_{VCO} represents how much the VCO frequency changes for each volt applied at the control pin. It is assumed (but

probably is not) linear about the lock point (2.5V). Its value depends on the VCO configuration and the varactor transfer function $C_V = F(V_C)$, where V_C is the reverse bias control voltage, and C_V is varactor capacitance. Since $F(V_C)$ is nonlinear, it is probably best to build the VCO and measure K_{VCO} about 2.5V. The results of one such measurement are shown below. The slope of the curve is determined by linear regression techniques and equals K_{VCO} . For our example, $K_{VCO} = 9.06\text{ Mrad/s/V}$.

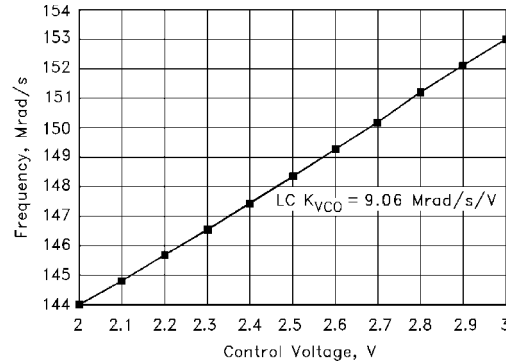


FIGURE 11. FOSC vs VC, LC VCO

5. Now we can solve for C_3 , C_4 , and R_3 in Equation 7:

$$C_3 = \frac{K_d K_{VCO}}{N \omega_n^2} = \frac{(4.77\text{e-}5)(9.06\text{e}6)}{(1820)(5000)^2} = 0.01\mu\text{F}$$

$$C_4 = \frac{C_3}{10} = 0.001\mu\text{F} \quad (\text{EQ. 7})$$

$$R_3 = \frac{2N\zeta\omega_n}{K_d K_{VCO}} = \frac{(2)(1820)(1)(5000)}{(4.77\text{e-}5)(9.06\text{e}6)} = 42.1\text{k}\Omega$$

We choose $R_3 = 43\text{k}\Omega$ for convenience.

6. Notice R_2 has little effect on the loop filter design. R_2 should be large, around 100k, and can be adjusted to compensate for any static phase error T_0 at lock, but if made too large, will slow loop response. If R_2 is made smaller, T_0 (see "Timing Diagrams" on page 5) increases, and if R_2 increases, T_0 decreases. For LDET to be low at lock, $|T_0| < 50\text{ns}$. C_4 is used mainly to attenuate high frequency noise from the charge pump. The effect these components have on-time to lock is illustrated in Figure 12.

Lock Time

Let $T = R_3 C_3$. As T increases, damping increases, but so does lock time. Decreasing T decreases damping and speeds up loop response, but increases overshoot and thus increases the number of hunting oscillations before lock. Critical damping ($\zeta=1$) occurs at minimum lock time. Because decreased damping also decreases loop stability, it is sometimes desirable to design slightly overdamped ($\zeta>1$), trading lock time for increased stability.

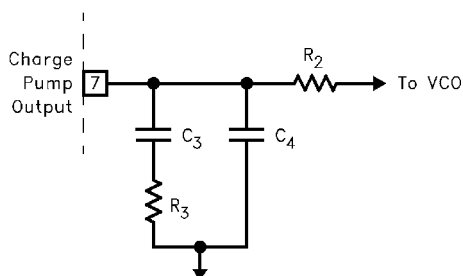


FIGURE 12. TYPICAL LOOP FILTER

LC LOOP FILTER COMPONENTS (APPROXIMATE)

FREQUENCY (MHz)	R ₂ (kΩ)	R ₃ (kΩ)	C ₃ (μF)	C ₄ (μF)
26.602	100	39	0.01	0.001
27.0	100	39	0.01	0.001
29.5	100	43	0.01	0.001
35.468	100	51	0.01	0.001
21.476	100	30	0.01	0.001
24.546	100	36	0.01	0.001
28.636	100	43	0.01	0.001

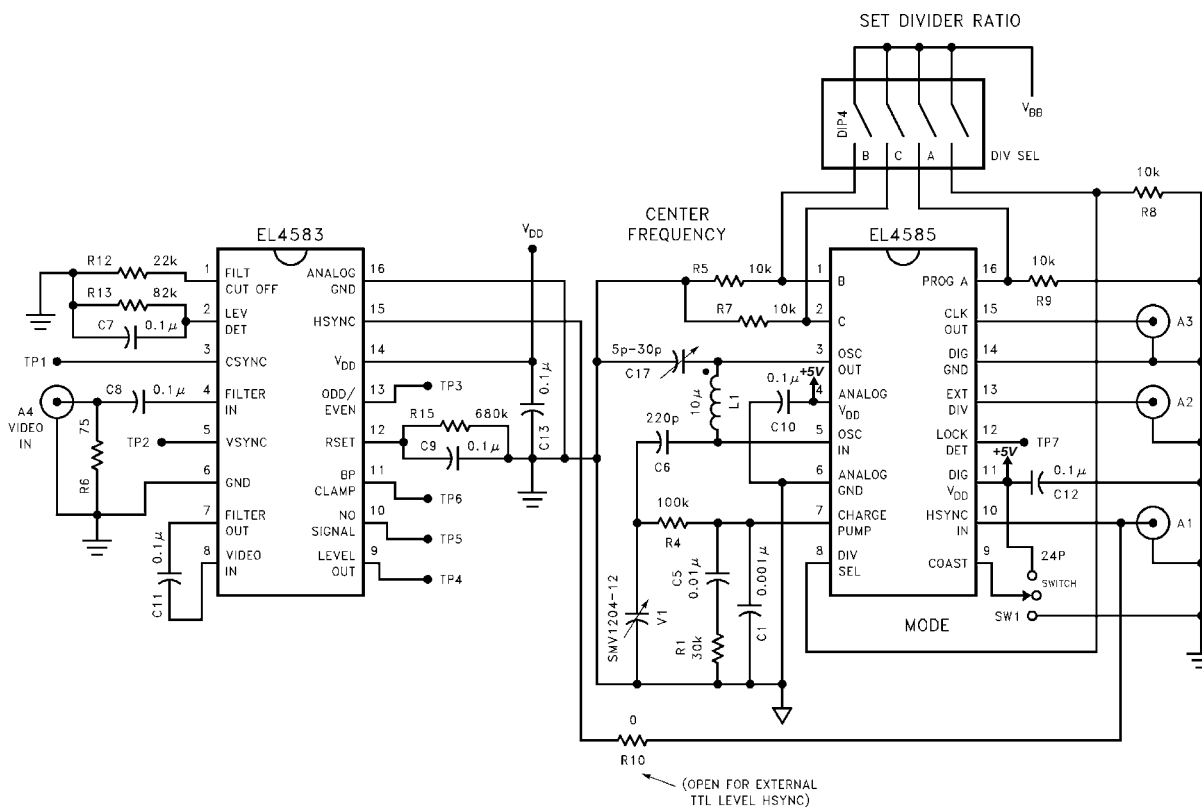
XTAL LOOP FILTER COMPONENTS (APPROXIMATE)

FREQUENCY (MHz)	R ₂ (kΩ)	R ₃ (MΩ)	C ₃ (pF)	C ₄ (pF)
26.602	100	4.3	68	6.8
27.0	100	4.3	68	6.8
29.5	100	4.3	68	6.8
35.468	100	4.3	68	6.8
21.476	100	4.3	68	6.8
24.546	100	4.3	68	6.8
28.636	100	4.3	68	6.8

PCB Layout Considerations

It is highly recommended that power and ground planes be used in layout. The oscillator and filter sections constitute a feedback loop and thus care must be taken to avoid any feedback signal influencing the oscillator except at the control input. The entire oscillator/filter section should be surrounded by copper ground to prevent unwanted influences from nearby signals. Use separate paths for analog and digital supplies, keeping the analog (oscillator section) as short and free from spurious signals as possible. Careful attention must be paid to correct bypassing. Keep lead lengths short and place bypass caps as close to the supply pins as possible. If laying out a PCB to use discrete components for the VCO section, care must be taken to avoid parasitic capacitance at the OSC pins 3 and 5, and FILTER out (pin 7). Remove ground and power plane copper above and below these traces to avoid making a capacitive connection to them. It is also recommended to enclose the oscillator section within a shielded cage to reduce external influences on the VCO, as they tend to be very sensitive to "hand waving" influences, the LC variety being more sensitive than crystal controlled oscillators. In general, the higher the operating frequency, the more important these considerations are. Self contained VCXO or VCO modules are already mounted in a shielding cage and therefore do not require as much consideration in layout. Many crystal manufacturers publish informative literature regarding use and layout of oscillators which should be helpful.

EL4585/4 Demo Board



The VCO and loop filter section of the EL4583/4/5 Demo Board can be implemented in the following configurations:

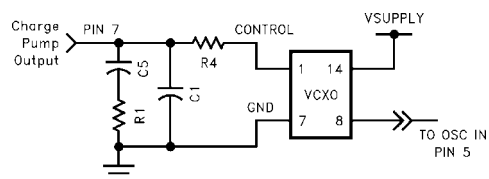


FIGURE 13. VCXO

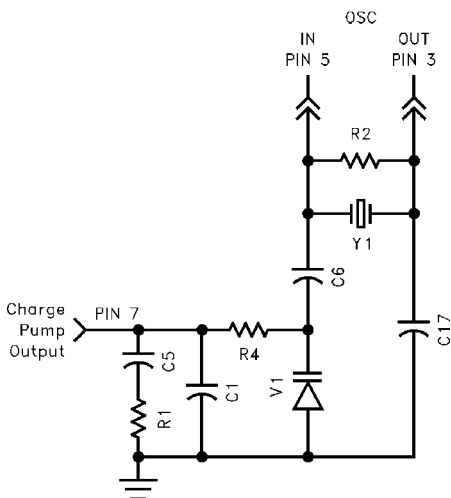


FIGURE 14. XTAL

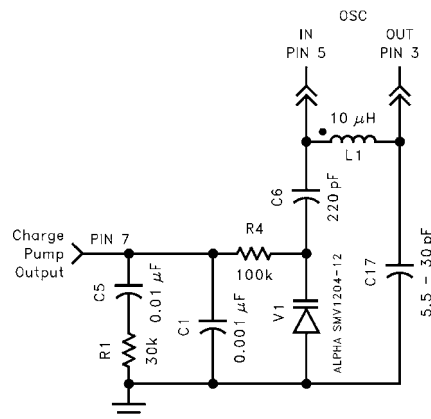


FIGURE 15. LC TANK

Component Sources

Inductors

- Dale Electronics
E. Highway 50
PO Box 180
Yankton, SD 57078-0180
(605) 665-9301

Crystals, VCXO, VCO Modules

- Connor-Winfield
2111 Comprehensive Drive
Aurora, IL 60606
(708) 851-4722
- Piezo Systems
100 K Street
PO Box 619
Carlisle, PA 17013
(717) 249-2151
- Reeves-Hoffman
400 West North Street
Carlisle, PA 17013
(717) 243-5929

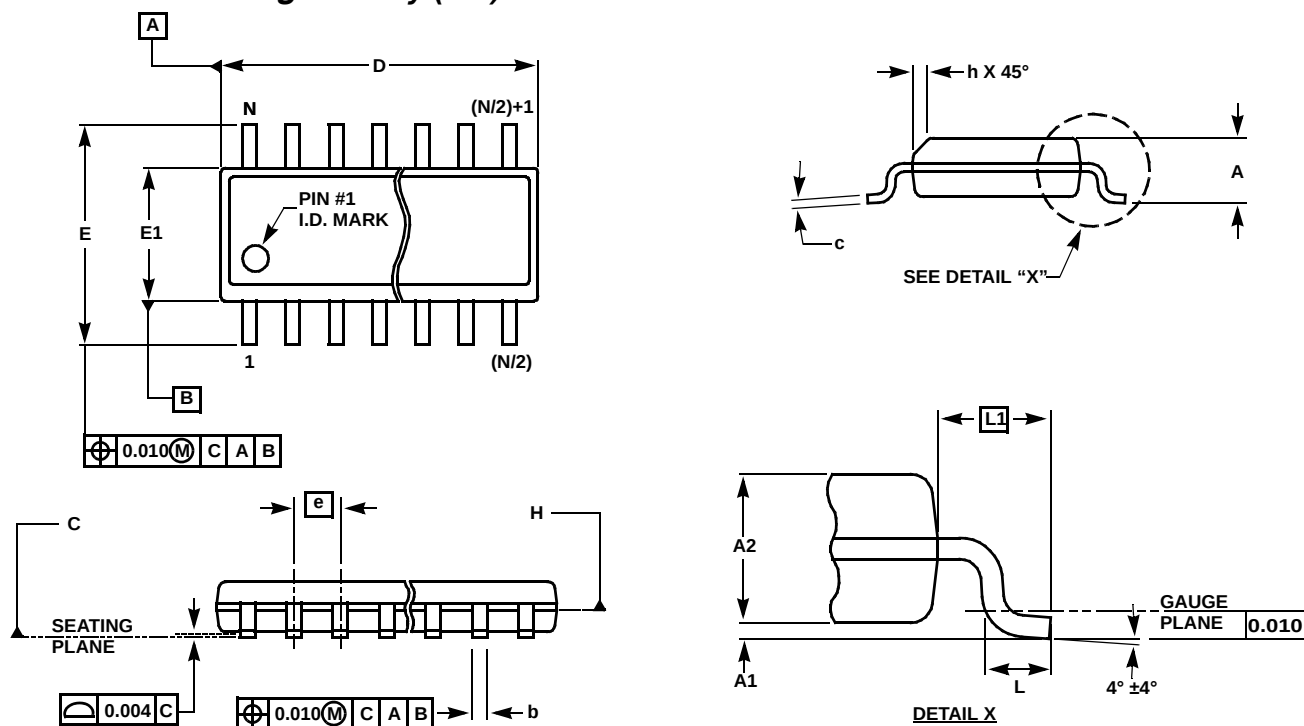
- SaRonix
151 Laura Lane
Palo Alto, CA 94043
(415) 856-6900
- Standard Crystal
9940 Baldwin Place
El Monte, CA 91731
(818) 443-2121

Varactors

- Sky Works Solutions Inc.
20 Sylvan Road
Woburn, MA 01801
(781) 376-3000
www.skyworksinc.com
- Motorola Semiconductor Products
2100 E. Elliot
Tempe, AZ 85284
(602) 244-6900

Note: These sources are provided for information purposes only. No endorsement of these companies is implied by this listing.

Small Outline Package Family (SO)



MDP0027

SMALL OUTLINE PACKAGE FAMILY (SO)

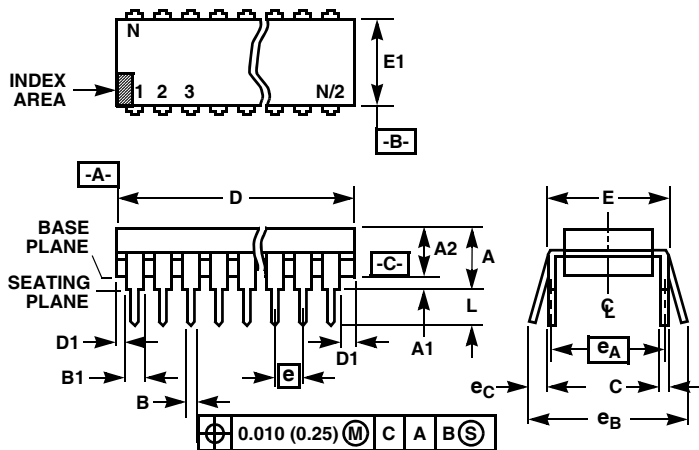
SYMBOL	INCHES							TOLERANCE	NOTES
	SO-8	SO-14	SO16 (0.150")	SO16 (0.300") (SOL-16)	SO20 (SOL-20)	SO24 (SOL-24)	SO28 (SOL-28)		
A	0.068	0.068	0.068	0.104	0.104	0.104	0.104	MAX	-
A1	0.006	0.006	0.006	0.007	0.007	0.007	0.007	±0.003	-
A2	0.057	0.057	0.057	0.092	0.092	0.092	0.092	±0.002	-
b	0.017	0.017	0.017	0.017	0.017	0.017	0.017	±0.003	-
c	0.009	0.009	0.009	0.011	0.011	0.011	0.011	±0.001	-
D	0.193	0.341	0.390	0.406	0.504	0.606	0.704	±0.004	1, 3
E	0.236	0.236	0.236	0.406	0.406	0.406	0.406	±0.008	-
E1	0.154	0.154	0.154	0.295	0.295	0.295	0.295	±0.004	2, 3
e	0.050	0.050	0.050	0.050	0.050	0.050	0.050	Basic	-
L	0.025	0.025	0.025	0.030	0.030	0.030	0.030	±0.009	-
L1	0.041	0.041	0.041	0.056	0.056	0.056	0.056	Basic	-
h	0.013	0.013	0.013	0.020	0.020	0.020	0.020	Reference	-
N	8	14	16	16	20	24	28	Reference	-

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NOTES:

1. Plastic or metal protrusions of 0.006" maximum per side are not included.
2. Plastic interlead protrusions of 0.010" maximum per side are not included.
3. Dimensions "D" and "E1" are measured at Datum Plane "H".
4. Dimensioning and tolerancing per ASME Y14.5M-1994

Dual-In-Line Plastic Packages (PDIP)



NOTES:

1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
4. Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
6. E and e_A are measured with the leads constrained to be perpendicular to datum $-C-$.
7. e_B and e_C are measured at the lead tips with the leads unconstrained. e_C must be zero or greater.
8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
9. N is the maximum number of terminal positions.
10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

E16.3 (JEDEC MS-001-BB ISSUE D) 16 LEAD DUAL-IN-LINE PLASTIC PACKAGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	-	0.210	-	5.33	4
A1	0.015	-	0.39	-	4
A2	0.115	0.195	2.93	4.95	-
B	0.014	0.022	0.356	0.558	-
B1	0.045	0.070	1.15	1.77	8, 10
C	0.008	0.014	0.204	0.355	-
D	0.735	0.775	18.66	19.68	5
D1	0.005	-	0.13	-	5
E	0.300	0.325	7.62	8.25	6
E1	0.240	0.280	6.10	7.11	5
e	0.100 BSC		2.54 BSC		-
e_A	0.300 BSC		7.62 BSC		6
e_B	-	0.430	-	10.92	7
L	0.115	0.150	2.93	3.81	4
N	16		16		9

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